General Description
The LMX1501A and the LMX1511 are high performance frequency synthesizers with integrated prescalers designed for RF operation up to 1.1 GHz. They are fabricated using National’s ABIC IV BiCMOS process.

The LMX1501A and the LMX1511 contain dual modulus prescalers which can select either a 64/65 or a 128/129 divide ratio at input frequencies of up to 1.1 GHz. Using a proprietary digital phase locked loop technique, the LMX1501A/11’s linear phase detector characteristics can generate very stable, low noise local oscillator signals. Serial data is transferred into the LMX1501A and the LMX1511 via a three line MICROWIRE™ interface (Data, Enable, Clock). Supply voltage can range from 2.7V to 5.5V. The LMX1501A and the LMX1511 feature very low current consumption, typically 6 mA at 3V.

The LMX1501A is available in a JEDEC 16-pin surface mount plastic package. The LMX1511 is available in a TSSOP 20-pin surface mount plastic package.

Features
- RF operation up to 1.1 GHz
- 2.7V to 5.5V operation
- Low current consumption: $I_{CC} = 6$ mA (typ) at $V_{CC} = 3$V
- Dual modulus prescaler: 64/65 or 128/129
- Internal balanced, low leakage charge pump
- Small-outline, plastic, surface mount JEDEC, 0.150” wide, (1501A) or TSSOP, 0.173” wide, (1511) package

Applications
- Cellular telephone systems (AMPS, NMT, ETACS)
- Portable wireless communications (PCS/PCN, Cordless)
- Advanced cordless telephone systems (CT-1/CT-1+, CT-2, ISM902-928)
- Other wireless communication systems

Block Diagram

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### Pin Descriptions

<table>
<thead>
<tr>
<th>Pin No.</th>
<th>Pin No.</th>
<th>Pin Name</th>
<th>I/O</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>1501A</td>
<td>1511</td>
<td>1501A/1511</td>
<td></td>
<td></td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>OSCIN</td>
<td>I</td>
<td>Oscillator input. A CMOS inverting gate input intended for connection to a crystal resonator for operation as an oscillator. The input has a $V_{CC}/2$ input threshold and can be driven from an external CMOS or TTL logic gate. May also be used as a buffer for an externally provided reference oscillator.</td>
</tr>
<tr>
<td>2</td>
<td>3</td>
<td>OSCOUT</td>
<td>O</td>
<td>Oscillator output.</td>
</tr>
<tr>
<td>3</td>
<td>4</td>
<td>$V_P$</td>
<td>O</td>
<td>Power supply for charge pump must be $\geq V_{CC}$.</td>
</tr>
<tr>
<td>4</td>
<td>5</td>
<td>$V_{CC}$</td>
<td>O</td>
<td>Power supply voltage input. Input may range from 2.7V to 5.5V. Bypass capacitors should be placed as close as possible to this pin and be connected directly to the ground plane.</td>
</tr>
<tr>
<td>5</td>
<td>6</td>
<td>$D_o$</td>
<td>O</td>
<td>Internal charge pump output. For connection to a loop filter for driving the input of an external VCO.</td>
</tr>
<tr>
<td>6</td>
<td>7</td>
<td>GND</td>
<td>O</td>
<td>Ground.</td>
</tr>
<tr>
<td>7</td>
<td>8</td>
<td>LD</td>
<td>O</td>
<td>Lock detect. Output provided to indicate when the VCO frequency is in &quot;lock&quot;. When the loop is locked, the pin's output is HIGH with narrow low pulses.</td>
</tr>
<tr>
<td>8</td>
<td>9</td>
<td>$f_{IN}$</td>
<td>I</td>
<td>Prescaler input. Small signal input from the VCO.</td>
</tr>
<tr>
<td>9</td>
<td>10</td>
<td>CLOCK</td>
<td>I</td>
<td>High impedance CMOS Clock input. Data is clocked in on the rising edge, into the various counters and registers.</td>
</tr>
<tr>
<td>10</td>
<td>11</td>
<td>DATA</td>
<td>I</td>
<td>Binary serial data input. Data entered MSB first. LSB is control bit. High impedance CMOS input.</td>
</tr>
<tr>
<td>11</td>
<td>12</td>
<td>LE</td>
<td>I</td>
<td>Load enable input (with internal pull-up resistor). When LE transitions HIGH, data stored in the shift registers is loaded into the appropriate latch (control bit dependent). Clock must be low when LE toggles high or low. See Serial Data Input Timing Diagram.</td>
</tr>
<tr>
<td>12</td>
<td>13</td>
<td>FC</td>
<td>I</td>
<td>Phase control select (with internal pull-up resistor). When FC is LOW, the polarity of the phase comparator and charge pump combination is reversed.</td>
</tr>
<tr>
<td>13</td>
<td>14</td>
<td>BISW</td>
<td>O</td>
<td>Analog switch output. When LE is HIGH, the analog switch is ON, routing the internal charge pump output through BISW (as well as through $D_o$).</td>
</tr>
<tr>
<td>14</td>
<td>15</td>
<td>$f_P$</td>
<td>O</td>
<td>Monitor pin of phase comparator input. Programmable reference divider output.</td>
</tr>
<tr>
<td>15</td>
<td>16</td>
<td>$f_{OUT}$</td>
<td>O</td>
<td>Monitor pin of phase comparator input. Programmable divider output.</td>
</tr>
<tr>
<td>16</td>
<td>17</td>
<td>$f_{OUT}$</td>
<td>O</td>
<td>Monitor pin of phase comparator input. CMOS Output.</td>
</tr>
<tr>
<td>17</td>
<td>18</td>
<td>$f_P$</td>
<td>O</td>
<td>Output for external charge pump. $f_P$ is an open drain N-channel transistor and requires a pull-up resistor.</td>
</tr>
<tr>
<td>18</td>
<td>19</td>
<td>$f_P$</td>
<td>O</td>
<td>Output for external charge pump. $f_P$ is a CMOS logic output.</td>
</tr>
<tr>
<td>X</td>
<td>2,9,12,19</td>
<td>NC</td>
<td></td>
<td>No connect.</td>
</tr>
</tbody>
</table>
Absolute Maximum Ratings (Note 1)
If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

- Power Supply Voltage
  - $V_{CC}$: $-0.3\text{V}$ to $+6.5\text{V}$
  - $V_P$: $-0.3\text{V}$ to $+6.5\text{V}$
- Voltage on Any Pin with GND = 0V ($V_I$): $-0.3\text{V}$ to $+6.5\text{V}$
- Storage Temperature Range ($T_S$): $-65^\circ\text{C}$ to $+150^\circ\text{C}$
- Lead Temperature ($T_L$) (solder, 4 sec.): $+260^\circ\text{C}$

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is intended to be functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed.

Recommended Operating Conditions
Power Supply Voltage
- $V_{CC}$: 2.7V to 5.5V
- $V_P$: $V_{CC}$ to 5.5V

Operating Temperature ($T_A$): $-40^\circ\text{C}$ to $+85^\circ\text{C}$

Electrical Characteristics, $V_{CC} = 5.0\text{V}$, $V_P = 5.0\text{V}$; $-40^\circ\text{C} < T_A < 85^\circ\text{C}$, except as specified

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Conditions</th>
<th>Min</th>
<th>Typ</th>
<th>Max</th>
<th>Units</th>
</tr>
</thead>
<tbody>
<tr>
<td>$I_{CC}$</td>
<td>Power Supply Current</td>
<td>$V_{CC} = 3.0\text{V}$</td>
<td>6.0</td>
<td>8.0</td>
<td>mA</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$V_{CC} = 5.0\text{V}$</td>
<td>6.5</td>
<td>8.5</td>
<td>mA</td>
<td></td>
</tr>
<tr>
<td>$f_{IN}$</td>
<td>Maximum Operating Frequency</td>
<td></td>
<td>1.1</td>
<td></td>
<td></td>
<td>GHz</td>
</tr>
<tr>
<td>$f_{OSC}$</td>
<td>Maximum Oscillator Frequency</td>
<td></td>
<td>20</td>
<td></td>
<td></td>
<td>MHz</td>
</tr>
<tr>
<td>$f_p$</td>
<td>Maximum Phase Detector Frequency</td>
<td></td>
<td>10</td>
<td></td>
<td></td>
<td>MHz</td>
</tr>
<tr>
<td>$P_{FIN}$</td>
<td>Input Sensitivity</td>
<td>$V_{CC} = 2.7\text{V}$ to $5.5\text{V}$</td>
<td>$-10$</td>
<td>$+6$</td>
<td>dBm</td>
<td></td>
</tr>
<tr>
<td>$V_{OSC}$</td>
<td>Oscillator Sensitivity</td>
<td>OscIn</td>
<td>0.5</td>
<td></td>
<td></td>
<td>VPP</td>
</tr>
<tr>
<td>$V_{IH}$</td>
<td>High-Level Input Voltage</td>
<td></td>
<td>0.7 $V_{CC}$</td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>$V_{IL}$</td>
<td>Low-Level Input Voltage</td>
<td></td>
<td>$0.3 V_{CC}$</td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>$I_{IH}$</td>
<td>High-Level Input Current (Clock, Data)</td>
<td>$V_{IH} - V_{CC} = 5.5\text{V}$</td>
<td>$-1.0$</td>
<td>1.0</td>
<td>$\mu$A</td>
<td></td>
</tr>
<tr>
<td>$I_{IL}$</td>
<td>Low-Level Input Current (Clock, Data)</td>
<td>$V_{IL} - 0\text{V}, V_{CC} = 5.5\text{V}$</td>
<td>$-1.0$</td>
<td>1.0</td>
<td>$\mu$A</td>
<td></td>
</tr>
<tr>
<td>$I_{OH}$</td>
<td>Oscillator Input Current</td>
<td></td>
<td>100</td>
<td></td>
<td></td>
<td>$\mu$A</td>
</tr>
<tr>
<td>$I_{OL}$</td>
<td>$V_{IL} = 0\text{V}, V_{CC} = 5.5\text{V}$</td>
<td>$-100$</td>
<td></td>
<td></td>
<td>$\mu$A</td>
<td></td>
</tr>
<tr>
<td>$I_{OH}$</td>
<td>High-Level Input Current (LE, FC)</td>
<td>$V_{IH} - V_{CC} = 5.5\text{V}$</td>
<td>$-1.0$</td>
<td>1.0</td>
<td>$\mu$A</td>
<td></td>
</tr>
<tr>
<td>$I_{OL}$</td>
<td>Low-Level Input Current (LE, FC)</td>
<td>$V_{IL} = 0\text{V}, V_{CC} = 5.5\text{V}$</td>
<td>$-100$</td>
<td>1.0</td>
<td>$\mu$A</td>
<td></td>
</tr>
</tbody>
</table>

*Except $f_{IN}$ and OscIn
## Electrical Characteristics

$V_{CC} = 5.0V, V_P = 5.0V; -40^\circ C < T_A < 85^\circ C$, except as specified (Continued)

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Conditions</th>
<th>Min</th>
<th>Typ</th>
<th>Max</th>
<th>Units</th>
</tr>
</thead>
<tbody>
<tr>
<td>$I_{Oy-source}$</td>
<td>Charge Pump Output Current</td>
<td>$V_{DO} = V_P/2$</td>
<td></td>
<td></td>
<td></td>
<td>mA</td>
</tr>
<tr>
<td>$I_{Oy}$</td>
<td>Sink</td>
<td>$V_{DO} = V_P/2$</td>
<td>5.0</td>
<td></td>
<td></td>
<td>mA</td>
</tr>
<tr>
<td>$I_{Oy-Tri}$</td>
<td>Charge Pump TRI-STATE® Current</td>
<td>$0.5\leq V_{DO} \leq V_P - 0.5V$ $T = 25^\circ C$</td>
<td>-5.0</td>
<td>5.0</td>
<td></td>
<td>nA</td>
</tr>
<tr>
<td>$V_{OH}$</td>
<td>High-Level Output Voltage</td>
<td>$I_{OH} = -1.0\ mA^{**}$ $V_{CC} - 0.8$</td>
<td></td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>$V_{OL}$</td>
<td>Low-Level Output Voltage</td>
<td>$I_{OL} = 1.0\ mA^{**}$ $V_{CC} - 0.4$</td>
<td></td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>$V_{OH}$</td>
<td>High-Level Output Voltage (OSCOUT)</td>
<td>$I_{OH} = -200\ \mu A$ $V_{CC} - 0.8$</td>
<td></td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>$V_{OL}$</td>
<td>Low-Level Output Voltage (OSCOUT)</td>
<td>$I_{OL} = 200\ \mu A$</td>
<td></td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>$I_{OL}$</td>
<td>Open Drain Output Current ($\phi_p$)</td>
<td>$V_{CC} = 5.0V, V_{OL} = 0.4V$</td>
<td>1.0</td>
<td></td>
<td></td>
<td>mA</td>
</tr>
<tr>
<td>$I_{OL}$</td>
<td>Open Drain Output Current ($\phi_p$)</td>
<td>$V_{OH} = 5.5V$</td>
<td></td>
<td>100</td>
<td></td>
<td>$\mu A$</td>
</tr>
<tr>
<td>$R_{ON}$</td>
<td>Analog Switch ON Resistance (1511)</td>
<td></td>
<td>100</td>
<td></td>
<td></td>
<td>$\Omega$</td>
</tr>
<tr>
<td>$t_{CS}$</td>
<td>Data to Clock Set Up Time</td>
<td>See Data Input Timing</td>
<td>50</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>$t_{CH}$</td>
<td>Data to Clock Hold Time</td>
<td>See Data Input Timing</td>
<td>10</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>$t_{CWH}$</td>
<td>Clock Pulse Width High</td>
<td>See Data Input Timing</td>
<td>50</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>$t_{CWL}$</td>
<td>Clock Pulse Width Low</td>
<td>See Data Input Timing</td>
<td>50</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>$t_{ES}$</td>
<td>Clock to Enable Set Up Time</td>
<td>See Data Input Timing</td>
<td>50</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>$t_{EW}$</td>
<td>Enable Pulse Width</td>
<td>See Data Input Timing</td>
<td>50</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
</tbody>
</table>

**Except OSCOUT**
Typical Performance Characteristics

**ICC vs VCC**

- Temperature: +25°C, +85°C, -40°C

**IDo TRI-STATE vs Do Voltage**

- Temperature: +90°C, +70°C, +25°C

**Charge Pump Current vs Do Voltage**

- Vp = 5.0V, 4.5V, 3.5V

**Charge Pump Current Variation**

- Vp = 3.0V, 5.0V

**Oscillator Input Sensitivity**

- Sensitivity (dB) vs Frequency (kHz)
Typical Performance Characteristics (Continued)

Input Sensitivity vs Frequency

Input Sensitivity at Temperature Variation, $V_{CC} = 5V$

LMX1501A Input Impedance vs Frequency
$V_{CC} = 2.7V$ to $5.5V$, $f_{IN}$ = 100 MHz to 1,600 MHz

Marker 1
- 500 MHz, Real = 67, Imag. = -317
Marker 2
- 900 MHz, Real = 24, Imag. = -150
Marker 3
- 1 GHz, Real = 19, Imag. = -126
Marker 4
- 1,500 MHz, Real = 9, Imag. = -63

LMX1511 Input Impedance vs Frequency
$V_{CC} = 2.7V$ to $5.5V$, $f_{IN}$ = 100 MHz to 1,600 MHz

Marker 1
- 500 MHz, Real = 69, Imag. = -330
Marker 2
- 900 MHz, Real = 36, Imag. = -193
Marker 3
- 1 GHz, Real = 35, Imag. = -172
Marker 4
- 1,500 MHz, Real = 30, Imag. = -106
Charge Pump Current Specification Definitions

\[ I_1 = \text{CP sink current at } V_{Do} = V_p - \Delta V \]
\[ I_2 = \text{CP sink current at } V_{Do} = V_p/2 \]
\[ I_3 = \text{CP sink current at } V_{Do} = \Delta V \]
\[ I_4 = \text{CP source current at } V_{Do} = V_p - \Delta V \]
\[ I_5 = \text{CP source current at } V_{Do} = V_p/2 \]
\[ I_6 = \text{CP source current at } V_{Do} = \Delta V \]

\[ \Delta V = \text{Voltage offset from positive and negative rails. Dependent on VCO tuning range relative to } V_{CC} \text{ and ground. Typical values are between 0.5V and 1.0V.} \]

1. \[ I_{Do-sink} \text{ vs } I_{Do-source} = \frac{|I_2| + |I_4|}{|I_2| + |I_5|} \times 100\% \]
2. \[ I_{Do-sink} \text{ vs } I_{Do-source} = \frac{|I_2| + |I_4|}{|I_2| + |I_5|} \times 100\% \]
3. \[ I_{Do-sink} \text{ vs } I_{Do-source} = \frac{|I_2| + |I_4|}{|I_2| + |I_5|} \times 100\% \]
4. \[ K_{ph} = \text{Phase detector/charge pump gain constant} = \frac{1}{2}\frac{I_2}{I_5} \]

RF Sensitivity Test Block Diagram

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Note 1: \( N = 10,000 \), \( R = 50 \), \( P = 64 \)

Note 2: Sensitivity limit is reached when the error of the divided RF output, \( f_{OUT} \), is greater than or equal to 1 Hz.
**Functional Description**

The simplified block diagram below shows the 19-bit data register, the 14-bit R Counter and the S Latch, and the 18-bit N Counter (intermediate latches are not shown). The data stream is clocked (on the rising edge) into the DATA input, MSB first. If the Control Bit (last bit input) is HIGH, the DATA is transferred into the R Counter (programmable reference divider) and the S Latch (prescaler select: 64/65 or 128/129). If the Control Bit (LSB) is LOW, the DATA is transferred into the N Counter (programmable divider).

**PROGRAMMABLE REFERENCE DIVIDER (R COUNTER) AND PRESCALER SELECT (S LATCH)**

If the Control Bit (last bit shifted into the Data Register) is HIGH, data is transferred from the 19-bit shift register into a 14-bit latch (which sets the 14-bit R Counter) and the 1-bit S Latch (S15, which sets the prescaler: 64/65 or 128/129). Serial data format is shown below.

**14-BIT PROGRAMMABLE REFERENCE DIVIDER RATIO (R COUNTER)**

<table>
<thead>
<tr>
<th>Divide Ratio</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
</tr>
</thead>
<tbody>
<tr>
<td>R</td>
<td>14</td>
<td>13</td>
<td>12</td>
<td>11</td>
<td>10</td>
<td>9</td>
<td>8</td>
<td>7</td>
</tr>
</tbody>
</table>

**1-BIT PRESCALER SELECT (S LATCH)**

<table>
<thead>
<tr>
<th>Prescaler Select</th>
<th>S</th>
</tr>
</thead>
<tbody>
<tr>
<td>128/129</td>
<td>0</td>
</tr>
<tr>
<td>64/65</td>
<td>1</td>
</tr>
</tbody>
</table>

**Notes:**
- Divide ratios less than 3 are prohibited.
- Divide ratio: 3 to 16383
- S1 to S14: These bits select the divide ratio of the programmable reference divider.
- C: Control bit (set to HIGH level to load R counter and S Latch)
- Data is shifted in MSB first.
**Functional Description (Continued)**

**PROGRAMMABLE DIVIDER (N COUNTER)**

The N counter consists of the 7-bit swallow counter (A counter) and the 11-bit programmable counter (B counter). If the Control Bit (last bit shifted into the Data Register) is LOW, data is transferred from the 19-bit shift register into a 7-bit latch (which sets the 7-bit Swallow (A) Counter) and an 11-bit latch (which sets the 11-bit programmable (B) Counter). Serial data format is shown below.

<table>
<thead>
<tr>
<th>C</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>1</td>
<td>2</td>
<td>3</td>
<td>4</td>
<td>5</td>
<td>6</td>
<td>7</td>
<td>8</td>
<td>9</td>
<td>10</td>
<td>11</td>
<td>12</td>
<td>13</td>
<td>14</td>
<td>15</td>
<td>16</td>
</tr>
</tbody>
</table>

**Note:** S8 to S18: Programmable counter divide ratio control bits (3 to 2047)

### 7-BIT SWALLOW COUNTER DIVIDE RATIO (A COUNTER)

<table>
<thead>
<tr>
<th>Divide Ratio A</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
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</thead>
<tbody>
<tr>
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<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>1</td>
</tr>
<tr>
<td><strong>127</strong></td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>1</td>
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</tbody>
</table>

**Note:** Divide ratio: 0 to 127

### 11-BIT PROGRAMMABLE COUNTER DIVIDE RATIO (B COUNTER)

<table>
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<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
<th>S</th>
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<td>1</td>
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<td>1</td>
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</tr>
</tbody>
</table>

**Note:** Divide ratio: 3 to 2047. (Divide ratios less than 3 are prohibited)

**PULSE SWALLOW FUNCTION**

\[ f_{VCO} = (P \times B + A) \times f_{OSC}/R \]

- **f_{VCO}**: Output frequency of external voltage controlled oscillator (VCO)
- **B**: Preset divide ratio of binary 11-bit programmable counter (3 to 2047)
- **A**: Preset divide ratio of binary 7-bit swallow counter (0 ≤ A ≤ 127, A ≤ B)
- **f_{OSC}**: Output frequency of the external reference frequency oscillator
- **R**: Preset divide ratio of binary 14-bit programmable reference counter (3 to 16383)
- **P**: Preset modulus of dual modulus prescaler (64 or 128)
Functional Description (Continued)

SERIAL DATA INPUT TIMING

Notes:
1. Parenthesis data indicates programmable reference divider data.
2. Data shifted into register on clock rising edge.
3. Data is shifted in MSB first.

Test Conditions: The Serial Data Input Timing is tested using a symmetrical waveform around $V_{CC}/2$. The test waveform has an edge rate of 0.6 V/ns with amplitudes of $2.2V @ V_{CC}$ and $5.5V$.

Phase Characteristics

In normal operation, the FC pin is used to reverse the polarity of the phase detector. Both the internal and any external charge pump are affected.

Depending upon VCO characteristics, FC pin should be set accordingly:

When VCO characteristics are like (1), FC should be set HIGH or OPEN CIRCUIT;

When VCO characteristics are like (2), FC should be set LOW.

When FC is set HIGH or OPEN CIRCUIT, the monitor pin of the phase comparator input, $f_{out}$, is set to the reference divider output, $f_r$. When FC is set LOW, $f_{out}$ is set to the programmable divider output, $f_p$.

VCO Characteristics

Phase difference detection range: $-2\pi$ to $2\pi$

The minimum width pump up and pump down current pulses occur at the $C_D$ pin when the loop is locked.

FC = HIGH
Analog Switch (1511 only)
The analog switch is useful for radio systems that utilize a frequency scanning mode and a narrow band mode. The purpose of the analog switch is to decrease the loop filter time constant, allowing the VCO to adjust to its new frequency in a shorter amount of time. This is achieved by adding another filter stage in parallel. The output of the charge pump is normally through the 

TL/W/12340–25

Typical Crystal Oscillator Circuit
A typical circuit which can be used to implement a crystal oscillator is shown below.

TL/W/12340–26

Typical Lock Detect Circuit
A lock detect circuit is needed in order to provide a steady LOW signal when the PLL is in the locked state. A typical circuit is shown below.

TL/W/12340–27
**Typical Application Example**

Operational Notes:

* VCO is assumed AC coupled.
** RIN increases impedance so that VCO output power is provided to the load rather than the PLL. Typical values are 10X to 200X depending on the VCO power level. RIN RF impedance ranges from 40X to 100X.
*** 50Ω termination is often used on test boards to allow use of external reference oscillator. For most typical products a CMOS clock is used and no terminating resistor is required. OSCIN may be AC or DC coupled. AC coupling is recommended because the input circuit provides its own bias. (See Figure below)

Proper use of grounds and bypass capacitors is essential to achieve a high level of performance.
Crosstalk between pins can be reduced by careful board layout.
This is a static sensitive device. It should be handled only at static free work stations.
Application Information

LOOP FILTER DESIGN

A block diagram of the basic phase locked loop is shown.

FIGURE 1. Basic Charge Pump Phase Locked Loop

An example of a passive loop filter configuration, including the transfer function of the loop filter, is shown in Figure 2.

Z(s) = \frac{s (C2 \cdot R2) + 1}{s^2 (C1 \cdot C2 \cdot R2) + sC1 + sC2}

FIGURE 2. 2nd Order Passive Filter

Define the time constants which determine the pole and zero frequencies of the filter transfer function by letting

\[ T2 = R2 \cdot C2 \]  
\[ T1 = R2 \cdot \frac{C1 \cdot C2}{C1 + C2} \]

The PLL linear model control circuit is shown along with the open loop transfer function in Figure 3. Using the phase detector and VCO gain constants \([K_p, K_{VCO}]\) and the loop filter transfer function \([Z(s)]\), the open loop Bode plot can be calculated. The loop bandwidth is shown on the Bode plot (\(f_p\)) as the point of unity gain. The phase margin is shown to be the difference between the phase at the unity gain point and \(-180^\circ\).

FIGURE 3. Open Loop Transfer Function

Thus we can calculate the 3rd order PLL Open Loop Gain in terms of frequency

\[ G(s) \cdot H(s)|_{s=j\omega} = -\frac{K_p \cdot K_{VCO}}{\omega^2 C1 \cdot N} \cdot \frac{1}{\omega^2 C1 \cdot N} \cdot \frac{1}{1 + j\omega \cdot T2} \cdot \frac{T1}{T2} \]  
(2)

From equation 2 we can see that the phase term will be dependent on the single pole and zero such that

\[ \phi(\omega) = \tan^{-1} \left( \omega \cdot T2 \right) - \tan^{-1} \left( \omega \cdot T1 \right) + 180^\circ \]  
(3)

By setting

\[ \frac{\phi}{d\omega} = \frac{T2}{1 + \omega^2 T2^2} \]  
\[ \frac{d\phi}{d\omega} = \frac{T1}{1 + \omega^2 T1^2} \]  
(4)

we find the frequency point corresponding to the phase inflection point in terms of the filter time constants T1 and T2. This relationship is given in equation 5.

\[ \omega_o = \frac{1}{\sqrt{T2 \cdot T1}} \]  
(5)

For the loop to be stable the unity gain point must occur before the phase reaches \(-180^\circ\) degrees. We therefore want the phase margin to be at a maximum when the magnitude of the open loop gain equals 1. Equation 2 then gives

\[ C1 = \frac{K_p \cdot K_{VCO} \cdot T1}{1 + j\omega_o \cdot T2} \]  
\[ \frac{\omega_o^2 \cdot N \cdot T2}{1 + j\omega_o \cdot T1} \]  
(6)
Therefore, if we specify the loop bandwidth, \( \omega_p \), and the phase margin, \( \phi_p \), Equations 1 through 6 allow us to calculate the two time constants, \( T_1 \) and \( T_2 \), as shown in equations 7 and 8. A common rule of thumb is to begin your design with a 45° phase margin.

\[
T_1 = \frac{\sec \phi_p - \tan \phi_p}{\omega_p} \\
T_2 = \frac{1}{\omega_p^2 \cdot T_1}
\]

From the time constants \( T_1 \), and \( T_2 \), and the loop bandwidth, \( \omega_p \), the values for \( C_1 \), \( R_2 \), and \( C_2 \) are obtained in equations 9 to 11.

\[
C_1 = \frac{T_1 \cdot K \phi \cdot K_{VCO}}{\omega_p^2 \cdot N} \sqrt{\frac{1 + (\omega_p \cdot T_2)^2}{1 + (\omega_p \cdot T_1)^2}} \\
C_2 = \frac{T_2 \cdot \left( \frac{T_1}{T_1 - 1} \right)}{} \\
R_2 = \frac{T_2}{C_2}
\]

**Application Information (Continued)**

In choosing the loop filter components a trade off must be made between lock time, noise, stability, and reference spurs. The greater the loop bandwidth the faster the lock time will be, but a large loop bandwidth could result in higher reference spurs. Wider loop bandwidths generally improve close in phase noise but may increase integrated phase noise depending on the reference input, VCO and division ratios used. The reference spurs can be reduced by reducing the loop bandwidth or by adding more low pass filter stages but the lock time will increase and stability will decrease as a result.

**THIRD ORDER FILTER**

A low pass filter section may be needed for some applications that require additional rejection of the reference sidebands, or spurs. This configuration is given in Figure 4. In order to compensate for the added low pass section, the component values are recalculated using the new open loop unity gain frequency. The degradation of phase margin caused by the added low pass is then mitigated by slightly increasing \( C_1 \) and \( C_2 \) while slightly decreasing \( R_2 \).

\[
ATTEN = 20 \log \left[ \frac{(2 \pi f_{\text{ref}}) \cdot R_3 \cdot C_3}{f_{\text{ref}}} \right] + 1
\]

Defining the additional time constant as \( T_3 = R_3 \cdot C_3 \) (13)

Then in terms of the attenuation of the reference spurs added by the low pass pole we have

\[
T_3 = \sqrt{\frac{10 \cdot ATTEN}{(2 \pi \cdot f_{\text{ref}})^2}} - 1
\]

We then use the calculated value for loop bandwidth \( \omega_c \) in equation 11, to determine the loop filter component values in equations 15–17. \( \omega_c \) is slightly less than \( \omega_p \), therefore the frequency jump lock time will increase.
Application Information (Continued)

Example 1

\[ K_{VCO} = 19.3 \text{ MHz/V} \]
\[ K_a = 5 \text{ mA (Note 1)} \]
\[ R\ell_{opt} = 868 \text{ MHz} \]
\[ f_{\text{ref}} = 25 \text{ kHz} \]
\[ N = \frac{R\ell_{opt}}{f_{\text{ref}}} = 35440 \]
\[ \omega_p = 2\pi \times 5 \text{ kHz} = 31415.93 \]
\[ \phi_p = 45^\circ \]
\[ \text{ATTEN} = 10 \text{ dB} \]

\[
T_1 = \frac{\sec \phi_p - \tan \phi_p}{\omega_p} = 1.38e-5
\]

\[
T_3 = \frac{\sqrt{\frac{10(10/20) - 1}{(2\pi \times 25e3)^2}}}{9.361e-6}
\]

\[
\omega_c = \left( \frac{(1.38e-5 + 9.361e-6)^2 + 1.38e-5 \times 9.361e-6}{(1.38e-5 + 9.361e-6)^2} \right) \times \left( \frac{1 + (1.38e-5 + 9.361e-6)^2}{(1.38e-5 + 9.361e-6)^2 - 1} \right) = 1.8101e4
\]

\[
T_2 = \frac{1}{(1.8101e4)^2 \times (1.38e-5 + 9.361e-6)} = 1.318e-4
\]

\[
C_1 = \frac{1.38e-5 - (5e-3) \times 19.3e6}{1.318e-4 \times (1.8101e4)^2 \times (35440)} \left[ \frac{1 + (1.8101e4)^2 \times (1.318e-4)^2}{1 + (1.8101e4)^2 \times (1.38e-5)^2} \frac{1 + (1.8101e4)^2 \times (9.361e-6)^2}{1 + (1.8101e4)^2 \times (9.361e-6)^2} \right]^{1/2} = 2.153 \text{nF}
\]

\[
C_2 = \frac{1.318e-4}{1.38e-5 - 1} = 18.35 \text{nF}
\]

\[
R_2 = \frac{1.318e-4}{18.35e-9} = 71.8 \text{k}\Omega
\]

If we choose \( R_3 = 120 \text{k}\Omega \), then \( C_3 = \frac{9.361e-6}{120e3} = 78 \text{ pF} \).

Converting to standard component values gives the following filter values, which are shown in Figure 4.

\[
C_1 = 2200 \text{ pF}
\]

\[
R_2 = 8.2 \text{k}\Omega
\]

\[
C_2 = 0.018 \mu\text{F}
\]

\[
R_3 = 120 \text{k}\Omega
\]

\[
C_3 = 78 \text{ pF}
\]

Note 1: See related equation for \( K_a \) in Charge Pump Current Specification Definitions. For this example \( V_p = 5.0 \text{V} \). The value for \( K_a \) can then be approximated using the curves in the Typical Performance Characteristics for Charge Pump Current vs \( D_v \) Voltage. The units for \( K_a \) are in mA. You may also use \( K_a = (5 \text{ mA} / 2\pi \text{ rad}) \), but in this case you must convert \( K_{VCO} \) to (rad/V) multiplying by \( 2\pi \).
Application Information (Continued)

**FIGURE 5. PLL Reference Spurs**
The reference spurious level is $< -66$ dBc, due to the loop filter attenuation and the low spurious noise level of the LMX1511.

**FIGURE 6. PLL Phase Noise 3.5 kHz Offset**
The phase noise level at 3 kHz offset is $-65$ dBc/Hz.

**FIGURE 7. PLL Phase Noise @ 150 Hz Offset**
The phase noise level at 150 Hz offset is $-75.5$ dBc/Hz.

**FIGURE 8. Frequency Jump Lock Time**
Of concern in any PLL loop filter design is the time it takes to lock in to a new frequency when switching channels. Figure 8 shows the switching waveforms for a frequency jump of 857 MHz–915 MHz. By narrowing the frequency span of the HP35310A Modulation Domain Analyzer enables evaluation of the frequency lock time to within ±1 kHz. The lock time is seen to be < 1.6 ms for a frequency jump of 58 MHz.
EXTERNAL CHARGE PUMP

The LMX PLLatinum series of frequency synthesizers are equipped with an internal balanced charge pump as well as outputs for driving an external charge pump. Although the superior performance of NSC’s on board charge pump eliminates the need for an external charge pump in most applications, certain system requirements are more stringent. In these cases, using an external charge pump allows the designer to take direct control of such parameters as charge pump voltage swing, current magnitude, TRI-STATE leakage, and temperature compensation.

One possible architecture for an external charge pump current source is shown in Figure 9. The signals \( w_p \) and \( w_r \) in the diagram, correspond to the phase detector outputs of the LMX1501/1511 frequency synthesizers. These logic signals are converted into current pulses, using the circuitry shown in Figure 9, to enable either charging or discharging of the loop filter components to control the output frequency of the PLL.

Referring to Figure 9, the design goal is to generate a current which is relatively constant to within 5V of the power supply rail. To accomplish this, it is important to establish as large of a voltage drop across \( R_5, R_8 \) as possible without saturating \( Q_2, Q_4 \). A voltage of approximately 300 mV provides a good compromise. This allows the current source reference being generated to be relatively repeatable in the absence of good \( Q_1, Q_2/Q_3, Q_4 \) matching. (Matched transistor pairs is recommended.) The \( w_p \) and \( w_r \) outputs are rated for a maximum output load current of 1 mA while 5 mA current sources are desired. The voltages developed across \( R_4, R_9 \) will consequently be approximately 258 mV, or 42 mV \( \beta \) through the \( Q_1, Q_2/Q_3, Q_4 \) pairs.

In order to calculate the value of \( R_7 \) it is necessary to first estimate the forward base to emitter voltage drop \( V_{fnp} \) of the transistors used, the \( V_{OL} \) drop of \( w_p \), and the \( V_{OH} \) drop of \( w_r \)’s under 1 mA loads. (\( w_p \)’s \( V_{OL} \) \( k \) 0.1V and \( w_r \)’s \( V_{OH} \) \( k \) 0.1V.) Knowing these parameters along with the desired current allow us to design a simple external charge pump. Separating the pump up and pump down circuits facilitates the nodal analysis and give the following equations.

\[
\begin{align*}
R_4 &= \frac{V_{Rs}}{V_p \cdot \ln \left( \frac{l_{source}}{l_{max}} \right)} \\
R_9 &= \frac{V_{Rb} - V_p \cdot \ln \left( \frac{l_{sink}}{l_{max}} \right)}{l_{sink}} \\
R_5 &= \frac{V_{Rs} \cdot (\beta_p + 1)}{l_{max} \cdot (\beta_p + 1) - l_{source}} \\
R_8 &= \frac{V_{Rb} \cdot (\beta_n + 1)}{l_{max} \cdot (\beta_n + 1) - l_{sink}} \\
R_6 &= \frac{(V_p - V_{VOLp}) - (V_{Rs} + V_{Vb})}{l_{max}} \\
R_7 &= \frac{(V_p - V_{VOHp}) - (V_{Rb} + V_{fn})}{l_{max}}
\end{align*}
\]

Therefore select:

\[
\begin{align*}
R_4 &= \frac{0.3V - 0.026 \cdot 1n(5.0mA/1.0mA)}{5mA} = 51.6\Omega \\
R_9 &= \frac{0.3V \cdot (50 + 1)}{1.0mA \cdot (50 + 1) - 5.0mA} = 332\Omega \\
R_5 &= \frac{0.3V \cdot (100 + 1)}{1.0mA \cdot (100 + 1) - 5.0mA} = 315.6\Omega \\
R_8 &= \frac{(5V - 0.1V) - (0.3V + 0.8V)}{1.0mA} = 3.8\kOmega
\end{align*}
\]
Physical Dimensions inches (millimeters)

JEDEC 16-Lead (0.150” Wide) Small Outline Molded Package (M)
Order Number LMX1501AM
For Tape and Reel Order Number LMX1501AMX (2500 Units per Reel)
NS Package Number M16A
Physical Dimensions (millimeters) (Continued)

![Physical Dimensions Diagram]

20-Lead (0.173" Wide) Thin Shrink Small Outline Package (TM)
Order Number LMX1511TM
For Tape and Reel Order Number LMX1511TMX (2500 Units per Reel)
NS Package Number MTC20

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